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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

ATTY, DOCKET NO. 501082.16 (98-0616.15)

APPLICATION NO. 09/652,580

APPLICANT(S)

Vishnu K. Agarwal

FILING DATE August 31, 2000

GROUP ART UNIT

<del>2812</del> 2825 EXAMINER | **U.S. PATENT DOCUMENTS** QOUMENT NUMBER DATE NAME CLASS **SUBCLASS** FILING DATE IF APPROPRIATE 3,649,886 03/14/72 Kooi OME 317 235 ĀĀ OME 4,717,602 01/05/88 Yamazaki 427 ΑB 53.1 CME AC 5,232,871 08/03/93 Ho 437 190 CME ΑD 5,552,339 09/03/96 Hsieh 437 190 CME 5,733,816 03/31/98 ΑE Iyer et al. 438 592 6,136,690 ΑF 10/24/00 Li 438 627 6,153,519 AG 11/28/00 Jain et al. 438 681 6,204,203 03/20/01 Narwankar et al. 785 ΑH 438 622 CME 6,245,662 06/12/01 Naik et al. 438 FOREIGN PATENT DOCUMENTS DOCUMENT NUMBER DATE COUNTRY **SUBCLASS** TRANSLATION CLASS YES 355011329 A 01/26/80 JP (Abstract only) X C IME 410070091 A 03/10/98 JP (Abstract only) X OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.) Anonymous, "Oxide-Free Dielectric/GaAs Interface With No Excess As", IBM Technical

CME

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**DATE CONSIDERED** 

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\* EXAMINER: Initial if reference considered, whether or notcriteria is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applican(s).



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ame	AA	6,107,152	08/22/00	Derderian		438	381	
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APPLICATION NO. 09/652,580

APPLICANT(S)
Vishnu K. Agarwal

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